



Metaphase
Technologies, Inc.

| Area Backlights

Backlights

Standard and MetaBright™ Series

Backlighting is one of the most popular forms of vision inspection illumination, providing maximum contrast between object and scene and producing a high contrast image with consistent edge definition. *Metaphase* Backlights combine the latest high brightness LEDs with exclusive optical lensing to create high intensity and uniform (+/- 5%), shadow-free illumination.

Connectorized and convenient 24VDC power supply features an onboard and integrated driver. Commonly applied to measuring, defect and hole detection, and determining the orientation of parts. *Metaphase* offers variety of backlights to suit the needs of various applications: area, linear, narrow, and our highly compact thin backlights. Backlights can be configured for wavelength and other specifications.



Metaphase Backlight in use on a pick and place factory line for cosmetic assembly.

Features:

- Up to 50 SMD LED's per inch array makes our backlights the brightest most stable backlights
- Exclusive optical lens provides high uniformity (+/- 5%), shadow-free backlight illumination
- High Density Precision Chip Technology (HDPCT)
- Patent-pending thermal management design draws heat directly from the die ensuring long life
- Metaphase Technologies has the largest selection of Backlights in the vision industry.
- Backlights with in-line and built-in strobe circuit available
 - (Simply provide 24VDC to power light and trigger signal to strobe the backlight)
- Backlight shapes/sizes include low profile, narrow and large area backlights
- Options include built-in line remote & potentiometer intensity control

Applications:

- Absence/presence of objects
 - Defect detection in glass/plastic containers
 - Object tracking (Fish in aquarium)
 - PCB (printed circuit board) board assembly through-hole lead detection
 - Web inspection (pin-holes in web)
 - Bottle cap detection
 - Bolt/Bolt thread inspection
 - Glass Sheet defect detection
 - Sub-pixel dimensional inspection
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